

Notice of References Cited	Application/Control No. 10/722,678 , 901007164		Applicant(s)/Patent Under Reexamination ISHIDA ET AL.	
	Examiner Lien T. Tran		Art Unit 1761	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0037350	03-2002	ISHII et al.	426/548
*	B	US-6,432,464	08-2002	Andersen et al.	426/548
*	C	US-5,510,508	04-1996	Claude et al.	560/41
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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